

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10659744	NABEYAMA ET AL.
	Examiner	Art Unit
	Tran, Dzung D	2613

SEARCHED

Class	Subclass	Date	Examiner
398	81, 147	12/09/2007	TD
	Update search	06/22/2008	TD

SEARCH NOTES

Search Notes	Date	Examiner
398/class as listed (USPAT; US-PGPUB; EPO; JPO and text search). See search history printout	12/09/2007	TD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner